

# AOT270AL/AOB270AL

75V N-Channel MOSFET

# **General Description**

The AOT270AL/AOB270AL uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{\text{DS(ON)}},$  Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

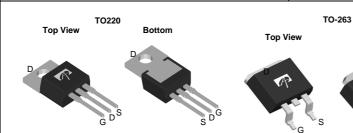
## **Product Summary**

 $\begin{array}{c} V_{DS} & 75V \\ I_{D} \; (at \; V_{GS} \text{=} 10V) & 140A \end{array} \label{eq:vds}$ 

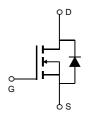
$$\begin{split} R_{DS(ON)} & (\text{at V}_{GS} \!\!=\!\! 10\text{V}) & < 2.6 \text{m}\Omega \quad (< 2.4 \text{m}\Omega^*) \\ R_{DS(ON)} & (\text{at V}_{GS} \!\!=\!\! 6\text{V}) & < 3.2 \text{m}\Omega \quad (< 3.0 \text{m}\Omega^*) \end{split}$$

100% UIS Tested 100% R<sub>g</sub> Tested









Absolute Maximum Ratings	T <sub>A</sub> =25℃ unless	otherwise noted
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Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	75	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	V	
Continuous Drain	T <sub>C</sub> =25℃		140		
Current <sup>G</sup>	T <sub>C</sub> =100℃	ID	110	Α	
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	560		
Continuous Drain	T <sub>A</sub> =25℃		21.5	^	
Current	T <sub>A</sub> =70℃	DSM	17	A	
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	120	Α	
Avalanche energy L=	0.1mH <sup>C</sup>	E <sub>AS</sub>	720	mJ	
	T <sub>C</sub> =25℃	В	500	W	
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	— P <sub>D</sub>	250	VV	
	T <sub>A</sub> =25℃	В	2.1	10/	
Power Dissipation A	T <sub>A</sub> =70℃	P <sub>DSM</sub>	1.3	W	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	C	

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	12	15	€/M
Maximum Junction-to-Ambient AD	Steady-State	ТθЈΑ	50	60	€/M
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.25	0.3	℃/W

<sup>\*</sup> Surface mount package TO263



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units	
STATIC F	PARAMETERS							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		75			V	
I <sub>DSS</sub> Zero Gate Voltage Drain Current	$V_{DS}$ =75V, $V_{GS}$ =0V				1	^		
		T <sub>J</sub> =55℃			5	μΑ		
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		2.2	2.7	3.3	V	
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V		560			Α	
		$V_{GS}$ =10V, $I_D$ =20A			2.15	2.6		
		TO220	T <sub>J</sub> =125℃		3.25	4		
R <sub>DS(ON)</sub> Static Drain-Source On-Resistance	$V_{GS}$ =6V, $I_D$ =20A			2.55	3.2			
	TO220			2.00	3.2	mΩ		
	$V_{GS}$ =10V, $I_{D}$ =20A			1.95	2.4	11122		
		TO263	T <sub>J</sub> =125℃		3.0	3.8		
		$V_{GS}$ =6V, $I_D$ =20A			2.25	2.0		
		TO263		2.35	3.0			
<b>g</b> FS	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =20A		80		S		
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.66	1	V		
Is	Maximum Body-Diode Continuous Curr	rrent <sup>G</sup>				140	Α	
DYNAMIC	PARAMETERS							
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =37.5V, f=1MHz			10830		pF	
Coss	Output Capacitance				1520		pF	
$C_{rss}$	Reverse Transfer Capacitance				97		pF	
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		0.3	0.75	1.2	Ω	
SWITCHI	NG PARAMETERS							
$Q_g$	Total Gate Charge				147	206	nC	
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =37.5V, I <sub>D</sub> =20A			38.5		nC	
$Q_{gd}$	Gate Drain Charge				30		nC	
t <sub>D(on)</sub>	Turn-On DelayTime				30		ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =37.5V, $R_{L}$ =1.9 $\Omega$ , $R_{GEN}$ =3 $\Omega$			20		ns	
t <sub>D(off)</sub>	Turn-Off DelayTime				66		ns	
t <sub>f</sub>	Turn-Off Fall Time				18		ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs			53		ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=500A/μ	.s		438		nC	

A. The value of R<sub>BJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation  $P_{DSM}$  is based on R  $_{\theta JA}$  and the maximum allowed junction temperature of 150 $^{\circ}$  C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175  $^{\circ}$  C may be used if the PCB allows it.

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B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175° C. Ratings are based on low frequency and duty cycles to keep initial  $T_J = 25^{\circ}$  C.

D. The  $R_{a,JC}$  is the sum of the thermal impedance from junction to case  $R_{a,JC}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max.

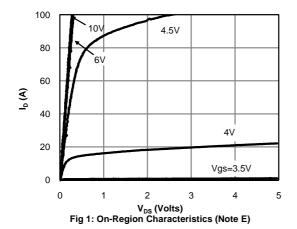
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

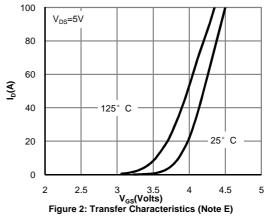
G. The maximum current limited by package is 140A.

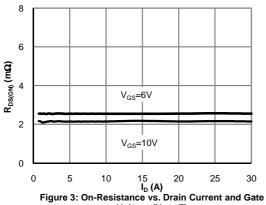
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

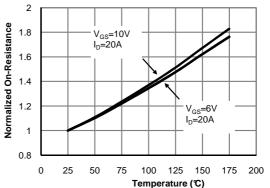


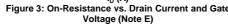
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

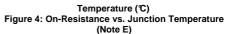


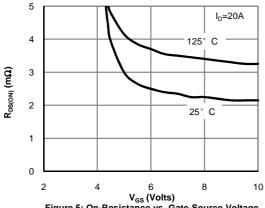












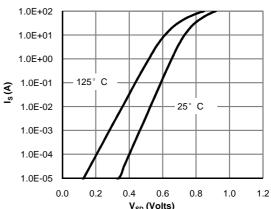
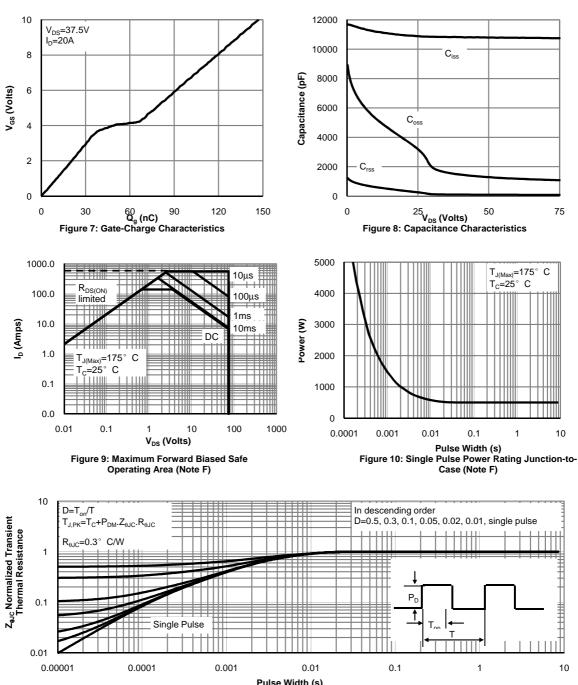


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

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#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

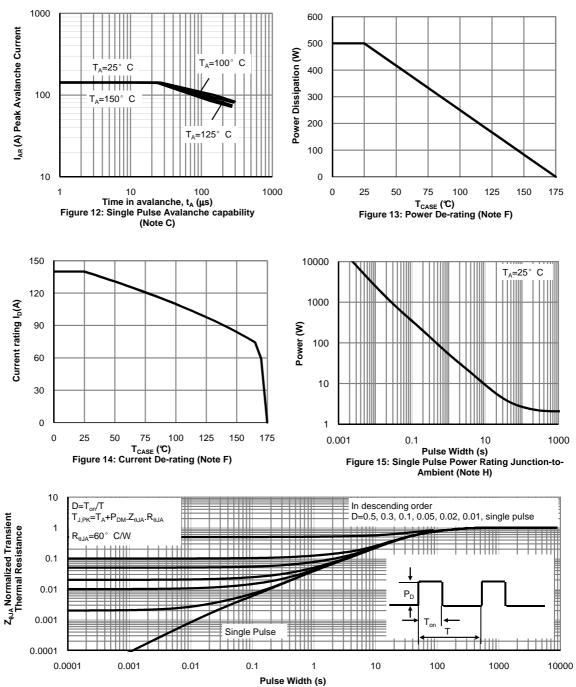
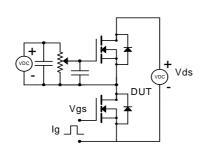


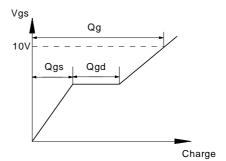
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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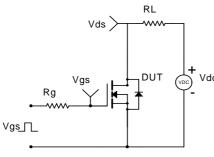


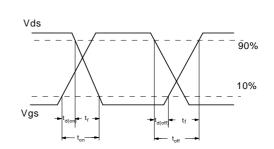
## Gate Charge Test Circuit & Waveform



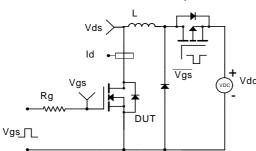


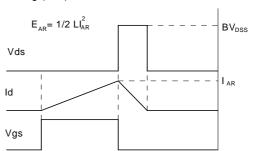
Resistive Switching Test Circuit & Waveforms



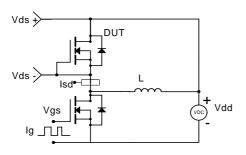


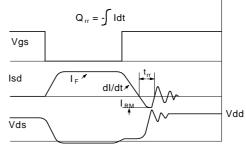
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





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